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App	lication	/Control	No.

Applicant(s)/Patent under Reexamination

10/005,483

Examiner

SNELL ET AL.

Art Unit

Ted M. Wang

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SEARCHED			
Class	Subclass	Date	Examiner
375	142	1/18/2006	TW
370	441, 479	1/18/2006	TW
	UPDATED		
375	130, 146	1/18/2006	TW
375	150	1/18/2006	TW
370	342	1/18/2006	TW

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
EAST - USPGPUB, USPAT, USOCR, EPO, JPO, DERWENT, IBM_TDB, see attached search report	1/18/2006	τw
IEEExplor- Advance Search- modified walsh code and DC reducing	1/18/2006	τw
IEEExplor- Advance Search - decode and orthogonal code and reduce average DC	1/18/2006	τw
Google -decode and orthogonal code and reduce average DC and modified walsh code	1/18/2006	TW